# onsemi

# **MOSFET** - Power, Single N-Channel, SO-8FL

30 V, 78 A

# NTMFS4C05N

# Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- CPU Power Delivery
- DC-DC Converters

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltag	ge		V <sub>DSS</sub>	30	V	
Gate-to-Source Voltag	e		V <sub>GS</sub>	±20	V	
Continuous Drain		T <sub>A</sub> = 25°C	۱ <sub>D</sub>	21.7	А	
Current $R_{\theta JA}$ (Note 1)		$T_A = 80^{\circ}C$		16.3		
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.57	W	
Continuous Drain		T <sub>A</sub> = 25°C	۱ <sub>D</sub>	34.8	А	
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		$T_A = 80^{\circ}C$		26.0		
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	6.6	W	
Continuous Drain		T <sub>A</sub> = 25°C	۱ <sub>D</sub>	11.9	А	
Current $R_{\theta JA}$ (Note 2)		$T_A = 80^{\circ}C$		8.9		
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.77	W	
Continuous Drain		$T_{C} = 25^{\circ}C$	I <sub>D</sub>	78	А	
Current $R_{\theta JC}$ (Note 1)		T <sub>C</sub> =80°C		58		
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	33	W	
Pulsed Drain Current	$T_A = 25^\circ$	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	174	А	
Current Limited by Pac	kage	$T_A = 25^{\circ}C$	I <sub>Dmax</sub>	80	А	
Operating Junction and Range	I Storage ⊺	lemperature	T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C	
Source Current (Body I	Diode)	iode)		30	А	
Drain to Source dV/dt	<sub>S</sub> = 20 V, I <sub>L</sub> = 41 A <sub>pk</sub> ,		dV/d <sub>t</sub>	7.0	V/ns	
Single Pulse Drain-to- Energy ( $T_J = 25^{\circ}C$ , $V_{G}$ L = 0.1 mH, $R_{GS} = 25^{\circ}S$			E <sub>AS</sub>	84	mJ	
Lead Temperature for S (1/8" from case for 10 s	Temperature for Soldering Purposes rom case for 10 s)			260	°C	

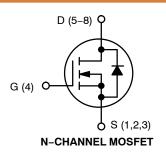
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

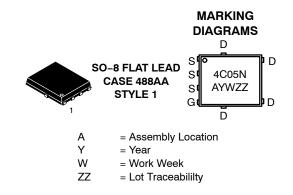
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at  $T_J = 25^{\circ}C$ ,

 $V_{GS}$  = 20 V, I<sub>L</sub> = 29 A, E<sub>AS</sub> = 42 mJ.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	$3.4~\mathrm{m}\Omega$ @ 10 V	78 A
30 V	5.0 mΩ @ 4.5 V	70A





#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4C05NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4C05NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	3.8	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	48.6	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	161.7	°C/W
Junction-to-Ambient – (t $\leq$ 10 s) (Note 4)	$R_{\thetaJA}$	19	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	V <sub>GS</sub> = 0 V, I <sub>D(aval</sub> T <sub>case</sub> = 25°C, t <sub>transi</sub>	<sub>)</sub> = 12.6 A, <sub>ent</sub> = 100 ns	34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				12		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.3		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.1		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		2.7	3.4	_
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.0	5.0	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			68		S
Gate Resistance	R <sub>G</sub>	$T_A = 25^{\circ}C$		0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1972		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz	z, V <sub>DS</sub> = 15 V		1215		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				59		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15	V, f = 1 MHz		0.030		
Total Gate Charge	Q <sub>G(TOT)</sub>				14		
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.3		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 1	5 V; I <sub>D</sub> = 30 A		6.0		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				5.0		1
Gate Plateau Voltage	V <sub>GP</sub>				3.1		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			30		nC
SWITCHING CHARACTERISTICS (Note 7)	,	•					
Turn-On Delay Time					11		

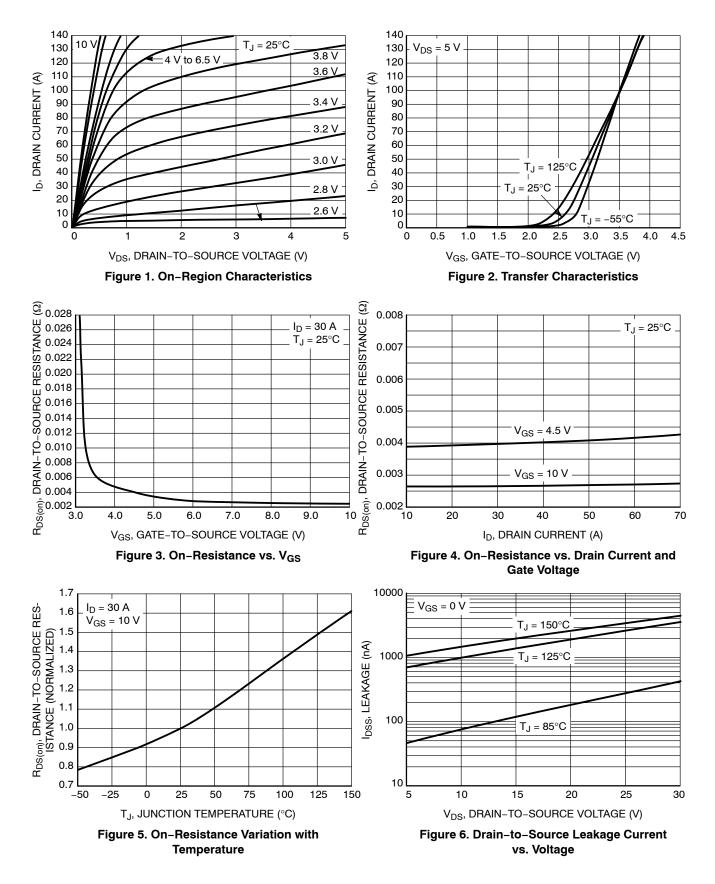
Turn-On Delay Time	t <sub>d(ON)</sub>		11		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	32	20	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D$ = 15 A, $R_G$ = 3.0 $\Omega$	21	ns	
Fall Time	t <sub>f</sub>		7.0		

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

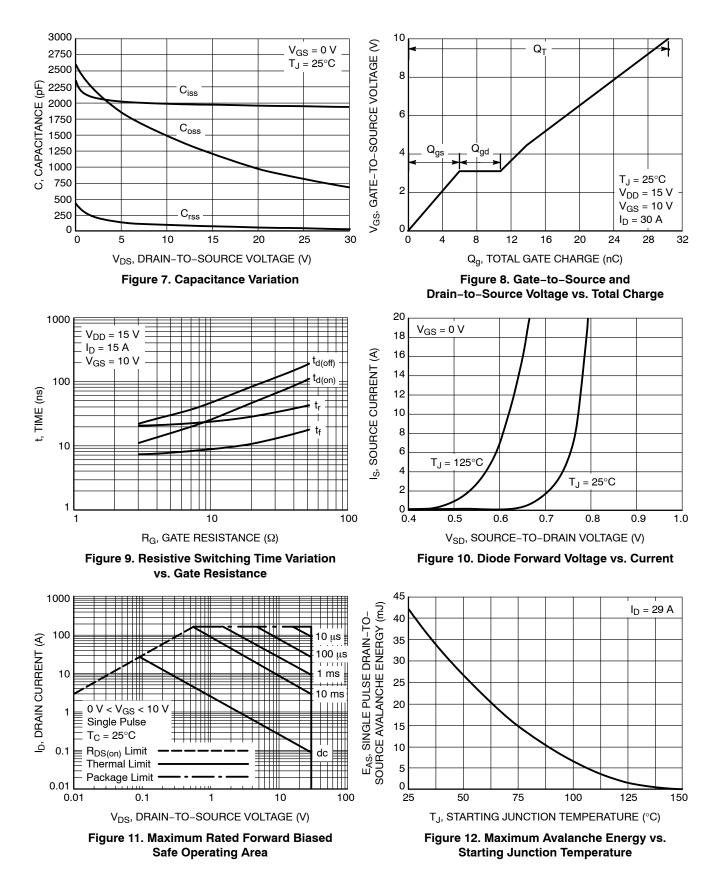
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
SWITCHING CHARACTERISTICS (No	ote 7)	•						
Turn-On Delay Time	t <sub>d(ON)</sub>				8.0			
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>		26		- ns		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 Ω			26			
Fall Time	t <sub>f</sub>				5.0			
DRAIN-SOURCE DIODE CHARACTE	RISTICS							
Forward Diode Voltage	V <sub>SD</sub>	$V_{CS} = 0 V.$ $T_{J} = 25^{\circ}C$		0.77	1.1	N		
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.62		V	
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/µs, I <sub>S</sub> = 30 A			40.2			
Charge Time	t <sub>a</sub>				20.3		ns	
Discharge Time	t <sub>b</sub>				19.9			
Reverse Recovery Charge	Q <sub>RR</sub>			30.2		nC		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Test: pulse width  $\leq 300 \ \mu$ s, duty cycle  $\leq 2\%$ . 7. Switching characteristics are independent of operating junction temperatures.

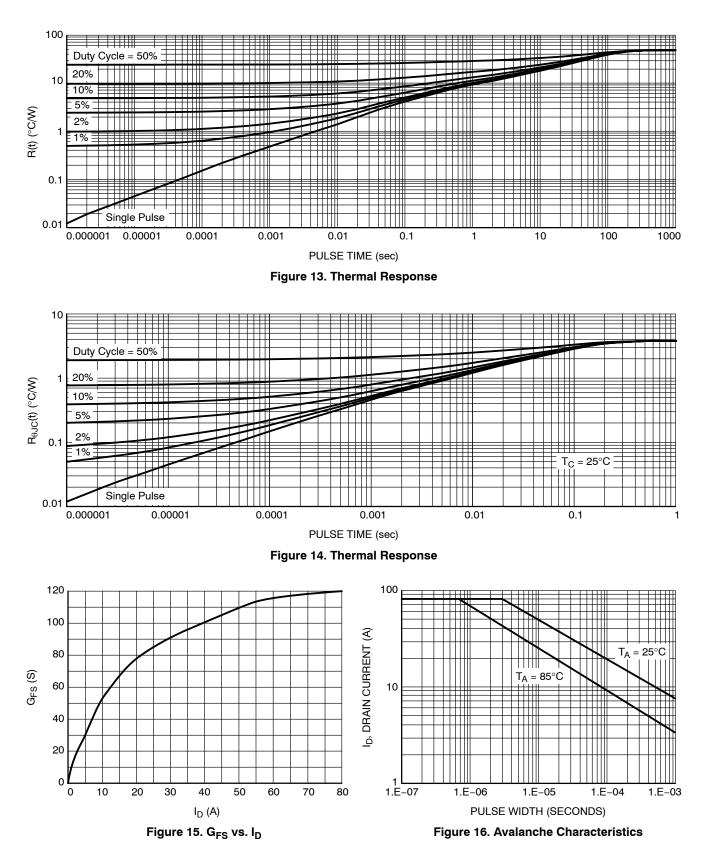
## **TYPICAL CHARACTERISTICS**



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